

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/029,929	BYSTED ET AL.	
Examiner	Art Unit	
F. Lin Khoo	2664	

SEARCHED				
Class	Subclass	Date	Examiner	
370	337	9/30/2005	FLK	
370	465	10/4/2005	FLK	
370	469	10/4/2005	FLK	
370	470	10/4/2005	FLK	
370	471	10/4/2005	FLK	
370	347	10/4/2005	FLK	
370	349	10/4/2005	FLK	
370	336	. 10/4/2005	FLK	
370	321	10/4/2005	FLK	
370	442	10/4/2005	FLK	
375	356	10/4/2005	FLK	
375	219	10/4/2005	FLK	
455	552.1	10/4/2005	FLK	

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
Plus Search	9/30/2005	FLK	
East Search	9/30/2005	FLK	
Consulted with Wellington Chin	10/4/2005	FLK	
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